AN8124K

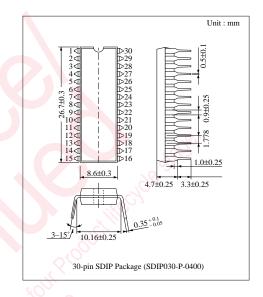
8-Bit A/D and D/A Compound Converter

Overview

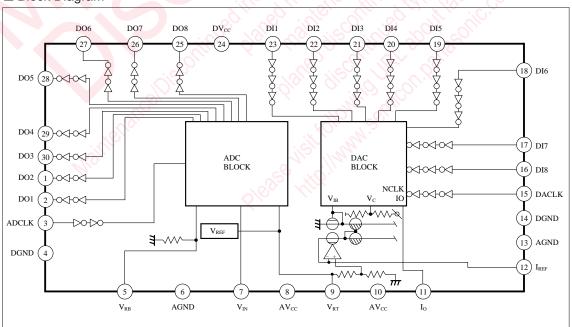
The AN8124K is a 8-bit A/D and D/A compound converter for image processing.

■ Features

- Reference Voltage Source Built-in
- Maximum conversion rate: 20 MSPS (min.)
- Sample holding circuit not required
- Low consumption power : 250 mW (typ.)
- Digital input/output level : TTL compatible



■ Block Diagram



■ Absolute Maximum Rating (Ta=25°C)

Parameter	Symbol	Rating	Unit
Supply voltage	V _{CC}	7	V
Supply current	I_{CC}	100	mA
Analogue input voltage	V _{IN}	-0.5 to $V_{CC} + 0.3$	V
Digital input voltage	V_{CLK}	-0.5 to $V_{CC} + 0.3$	V
Digital output current	I_{OH}	-15	mA
Digital output current	I_{OL}	15	mA
Reference resistive voltage	V_{RT}	-0.5 to $V_{CC} + 0.3$	V
Reference resistive voltage	V_{RB}	-0.5 to $V_{CC} + 0.3$	V
Digital input voltage	V_{DI}	-0.5 to $V_{CC} + 0.3$	V
Analogue output current	Io	30	·mA
Reference current	$I_{ m REF}$	10	mA
Power dissipation	P _D	700	mW
Operating ambient temperature	$T_{ m opr}$	-20 to + 70	°C
Storage temperature	T _{stg}	-55 to + 150	°C

■ Recommended Operating Conditions (Ta=25°C)

Parameter	Symbol	ol Condition		typ	max	Unit
Supply voltage	V _{cc}		4.75	5	5.25	V
Analogue input voltage	V _{IN}	160, 81	V_{RB}	_	V _{RT}	V
Output load resistance	Ro	9/13 (27);	_	220		Ω
Digital input voltage	V _{IH}	10M, 60,	2.4	_		V
Digital input voltage	$V_{\rm IL}$	30, On 110 110 1	(S)		0.8	V
Clock input pulse width	t_{WH}	Refer to the timing chart.	25			ns
Clock input pulse width	t_{WL}	Refer to the timing chart.	25	<u>_</u>	9	ns
Setting-up time	t _s	Refer to the timing chart.	20	<u> </u>	077	ns
Holding time	$t_{\rm H}$	Refer to the timing chart.	20	<u> </u>		ns

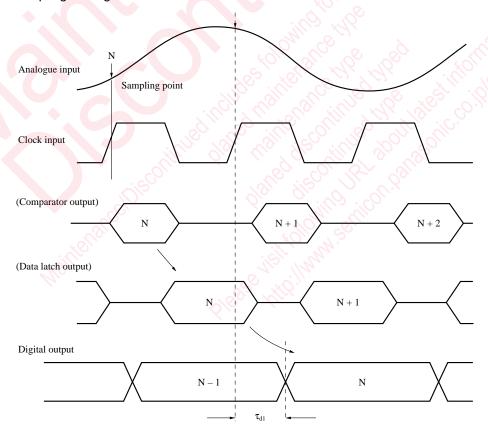
■ Electrical Characteristics (V_{CC}=5V, Ta=25°C)

Parameter	Symbol	Condition	min	typ	max	Unit
Supply current	I_{CC}	$f_{CLK}=15MHz, R_{REF}=1.8k\Omega$	<u> </u>	50	80	mA
Deference veltage	V_{RT}	Min die	3.1	3.5	3.9	V
Reference voltage	V_{RB}	V _{IN} = 2.5V	1.1	1.5	1.9	V
Input bias current	$I_{\rm IN}$	$V_{IN} = 2.4V$		40	120	μΑ
Clock input quality	I_{IH}	$V_{IL} = 0.4V$			30	μΑ
Clock input current	$I_{\rm IL}$	$I_{OH} = -2mA$	-30			μΑ
District to the	V_{OH}	I _{OL} =2mA	V _{CC} -0.8		_	V
Digital output voltage	V _{OL}				0.4	V
A/D, D/A						
Differential gain	DG			1		%
Differential phase	DP	$f_{IN} = 4MHz$, $f_S = 20MHz$		0.5		deg
Quantization noise	S/N		33	40	_	dB

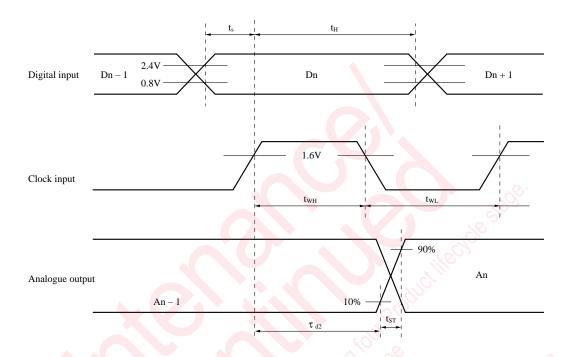
■ Electrical Characteristic (Cont.) (V_{CC}=5V, Ta=25°C)

Parameter	Symbol	Condition	min	typ	max	Unit
A/D						
Resolution	RES			8		bit
Maximum conversion rate	F _{CMAX}		20			MSPS
Linearity error	EL	$V_{RT} = 3.5V, V_{RB} = 1.5V$		±0.5	±1	LSB
Differential linearity error	E _D	$V_{RT} = 3.5V, V_{RB} = 1.5V$			±0.5	LSB
Equivalent input impedance	R _{IN}	V _{IN} = 2.5V		500		kΩ
Input capacitance	C _{IN}	$V_{IN} = 2.5V$		40		pF
Digital output delay	$ au_{d1}$			25		ns
D/A	•					
Resolution	RES			8	₹6.	bit
Maximum conversion rate	F _{CMAX}	$R_{OUT} = 220\Omega$, $R_{REF} = 1.8k\Omega$	20		(MSPS
Linearity error	E_L	$R_{OUT} = 220\Omega$, $R_{REF} = 1.8k\Omega$		<u> </u>	±0.5	LSB
Differential linearity error	E _D	$R_{OUT} = 220\Omega$, $R_{REF} = 1.8k\Omega$	_		±0.5	LSB
Full-Scale current	I_{FS}	$R_{OUT} = 220\Omega$, $R_{REF} = 1.8k\Omega$	3.64	4.55	5.45	mA
Settling time	t_{ST}	$R_{OUT} = 220\Omega$, $R_{REF} = 1.8k\Omega$	All'		50	ns
Analogue output delay	$ au_{ m d2}$		<u>52</u>	25		ns

■ A/D Sampling Timing Chart



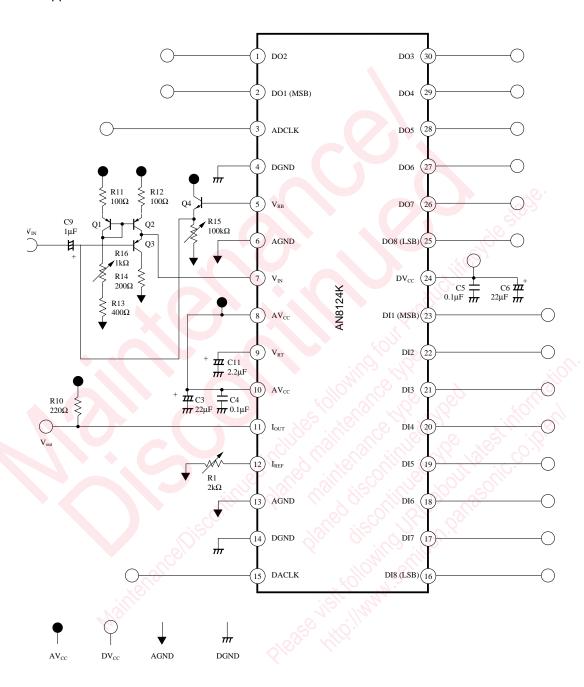
■ D/A Timing Chart



■ Pin Descriptions

Pin No.	Symbol	Pin name	Pin No.	Symbol	Pin name
1	DO2	Digital output 2-bit	16	DI8	Digital input 8-bit (LSB)
2	DO1	Digital output 1-bit (MSB)	17	DI7	Digital input 7-bit
3	ADCLK	A/D convertor clock input	18	DI6	Digital input 6-bit
4	DGND	Digital ground	19	DI5	Digital input 5-bit
5	V _{RB}	Reference voltage low level	20	DI4	Digital input 4-bit
6	AGND	Analogue ground	21	DI3	Digital input 3-bit
7	V _{IN}	Analogue input pin	22	DI2	Digital input 2-bit
8	AV _{CC}	Analogue power supply pin	23	DI1	Digital input 1-bit (MSB)
9	V _{RT}	Reference voltage high level	24	DV _{cc}	Digital power supply pin
10	AV _{CC}	Analogue power supply pin	25	DO8	Digital output 8-bit (LSB)
11	I _{OUT}	Analogue output	26	DO7	Digital output 7-bit
12	I _{REF}	Reference current setting	27	DO6	Digital output 6-bit
13	AGND	Analogue ground	28	DO5	Digital output 5-bit
14	DGND	Digital ground	29	DO4	Digital output 4-bit
15	DACLK	D/A convertor clock input	30	DO3	Digital output 3-bit

■ Application Circuit



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